

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/738,403	VAIDYANATHAN, JANAKIRAMAN
	Examiner	Art Unit
	John Wahnkyo Lee	2624

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NON-PATENT DOCUMENTS

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	U	Park et al., "Dual-beam structured-light scanning for 3-D object modeling," 28 May-1 June 2001, IEEE, pages 65-72□□
	V	Remondino Fabio, "3D Reconstruction of Articulated Objects from Uncalibrated Images," Jan. 2002, SPIE, Vol. 4661, pages 148-154
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.